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Application/Control No.	Applicant(s)/Patent under Reexamination
10/623,658	SHIN, HYOSEOP
Examiner	Art Unit
Charles E. Lu	2163

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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Consulted 101 Help Panel	8/8/2006	ÇL
Consulted Tim Vo and Don Wong (SPE)	8/4/2006	CL
Updated EAST Keyword Search See Attached	8/8/2006	CL